RF EXPOSURE REPORT FOR CERTIFICATION On Behalf of

mophie LLC

mophie snap + juice pack® mini stand

Model Number: SNP-JP-STND-5K

FCC ID: 2ACWB-5KAMZS

Applicant:	mophie LLC
Address:	6244 Technology Ave. Kalamazoo, MI 49009,
	United States of America.
Prepared By:	EST Technology Co., Ltd.
	Chilingxiang, Qishantou, Santun, Houjie, Dongguan, Guangdong, China
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Report Number:	ESTE-R2308170
Date of Test:	Aug. 04~09, 2023
Date of Report:	Aug. 11, 2023

EST Technology Co., Ltd Report No. ESTE-R2308170

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EST Technology Co., Ltd.

Applicant:

mophie LLC

Address:

6244 Technology Ave. Kalamazoo, MI 49009, United States of America.

Manufacturer:

mophie LLC

Address:

6244 Technology Ave. Kalamazoo, MI 49009, United States of America.

E.U.T:

mophie snap + juice pack® mini stand

Model Number:

SNP-JP-STND-5K

Power Supply:

Input: 5V===2.4A, 9V===2.22A

Output (USB-C): 5V===2.4A, Wireless: 5W/7.5W/10W

Wireless: 15W Max (Input 9V===2.22A)

Battery: 5000mAh, 3.85V

Trade Name:

mophie

Serial No.:

Date of Receipt:

Aug. 04, 2023

Date of Test:

Aug. 04~09, 2023

Test Specification:

FCC CFR 47 Part 1.1307(b)&1.1310

KDB 680106 D01 RF Exposure Wireless Charging Apps v03r01

Test Result:

The device described above is tested by EST Technology Co., Ltd. The measurement results were contained in this test report and EST Technology Co., Ltd. was assumed full responsibility for the accuracy and completeness of these measurements. Also, this report shows that the EUT to be technically compliance with the FCC CFR 47 Part 1.1307(b)&1.1310 requirements. This report applies to above tested sample only and shall not be reproduced in part without written

approval of EST Technology Co., Ltd.

Prepared by:

Reviewed by:

Ring Yang / Assistant

Seven Wang / Engineer

Iceman Hu / Manager

Other Aspects:

None.

Abbreviations: OK/P=passed

fail/F=failed

n.a/N=not applicable

E.U.T=equipment under tested

This test report is based on a single evaluation of one sample of above mentioned products, It is not permitted to be duplicated in extracts without written approval of EST Technology Co., Ltd.

1. SUMMARY OF TEST

1.1. Summary of test result

No.	Description of Test Item	FCC Standard Section	Results
1	Maximum Permissible Exposure	Part 1.1307(b)&1.1310	PASS

1.2. Test Mode

Test Item	Test Mode	
Maximum Permissible Exposure	Wireless Charging with Empty Load Wireless Charging with Half Load	
-	Wireless Charging with Full Load	

Note:

- 1: The worst Full Load status is recorded in the report.
- 2: Internal battery power mode and AC power mode all have been tested, only worse case Internal battery power mode is reported.

1.3. Test Equipment List

Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Next Cal.
Electric and Magnetic Field Probe-Analyzer	Narda S.T.S./PMM	EHP-200A	EST-E106	June 12,23	1 Year
Simulated load	/	/	EST-306	N/A	N/A
Simulated load	/	/	EST-307	N/A	N/A
Test Software	Narda	EHP200-TS	Rel 1.92	N/A	N/A

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2. MAXIMUM PERMISSIBLE EXPOSURE

2.1. Limit

Limits for Maximum Permissible Exposure (MPE)

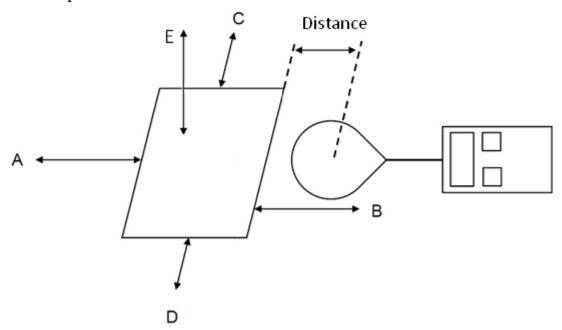
Frequency range (MHz)	Electric field strength (V/m)	Magnetic field strength (A/m)	Power density (mW/cm2)	Averaging time (minutes)				
(A) Limits for Occupational/Controlled Exposure								
0.3-3.0	614	1.63	*100	6				
3.0-30	1842/f	4.89/f	*900/f ²	6				
30-300	61.4	0.163	1.0	6				
300-1,500			f/300	6				
1,500-100,000			5	6				
	(B) Limits for Gene	eral Population/Und	controlled Exposure	ę				
0.3-1.34	614	1.63	*100	30				
1.34-30	824/f	2.19/f	*180/f ²	30				
30-300	27.5	0.073	0.2	30				
300-1,500			f/1500	30				
1,500-100,000			1.0	30				

Note:

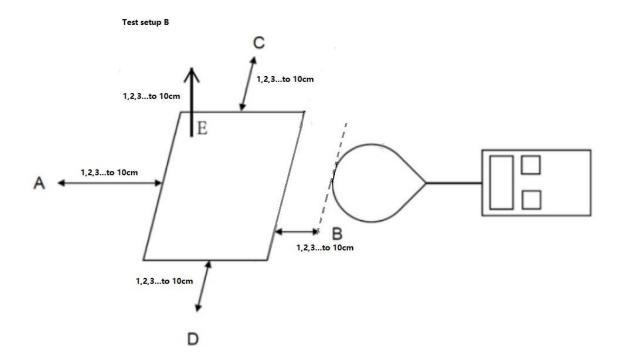
- 1. f = frequency in MHz * = Plane-wave equivalent power density.
- 2. For devices designed for typical desktop applications, such a wireless charging pads, RF exposure evaluation should be conducted assuming a user separation distance of 15 cm. E and H field strength measurements or numerical modeling may be used to demonstrate compliance. Measurements should be made from all sides and the top of the primary/client pair, with the 15 cm measured from the center of the probe(s) to the edge of the device. Emissions between 100 kHz to 300 kHz should be assessed versus the limits at 300 kHz in Table 1 of Section 1.1310: 614 V/m and 1.63 A/m. A KDB inquiry is required to determine the applicable exposure limits below 100 kHz.

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2.1. Test Setup A



2.2. Test Setup B



2.3. Test Procedure

- a. The test was performed on 360 degree turn table in anechoic chamber.
- b. The probe was placed at 15 cm surrounding the device and 20 cm above the top of the charger and the geometric centre of the probe, for test setup A.
- c. Measure magnetic and electrical field strength at a distance 10cm to 1cm at 1cm iteration, Which is between the edge of the charger and the edge of probe, for test setup B.
- d. The highest emission level was recorded and compared with limit as soon as measurement of each point; A, B, C, D, E were completed.
- e. The EUT was measured according to the dictates of KDB680106D01v03r01; TCB Workshop, October 2018, 5.2 RF Exposure Procedures.

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2.4. Equipment Approval Considerations

Inductive wireless power transfer applications with supporting field strength results and meeting all of the following requirements are not required to submit a KDB inquiry for devices approved using SDoC or a PAG for equipment approved using certification to address RF exposure compliance.

1	Power transfer frequency is less that 1 MHz						
1	YES; the device operated in the frequency range from 110.5-205KHz.						
2	Output power from each primary coil is less than or equal to 15 watts.						
4	YES; the maximum output power of the primary coil is 15w.						
	The system may consist of more than one source primary coils, charging one or more						
3	clients. If more than one primary coil is present, the coil pairs may be powered on at						
3	the same time.						
	YES; the transfer system includes only single primary and secondary coils.						
4	Client device is placed directly in contact with the transmitter.						
4	YES; Client device is placed directly in contact with the transmitter.						
	Mobile exposure conditions only (portable exposure conditions are not covered by						
5	this exclusion).						
	No.						
	The aggregate H-field strengths at 15 cm surrounding the device and 20 cm above the						
6	top surface from all simultaneous transmitting coils are demonstrated to be less than						
O	50% of the MPE limit.						
	YES; The EUT field strength levels are 50% x MPE limts.						

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2.5. Test Result for Test setupA:

	E-field strengt	h			
Frequency range (KHz) 110.5 to 205 kHz					
Test Mode	Full Load Half Load Emp				
Position A(V/m)	0.841	0.361	0.327		
Position B(V/m)	0.621	0.336	0.298		
Position C(V/m)	0.395	0.343	0.321		
Position D(V/m)	0.951	0.335	0.317		
Position E(V/m)	0.700	0.347	0.345		
Limits (V/m)	614				
50% Limits(V/m)	307				
	H-field strengt	h			
Frequency range (KHz)		110.5 to 205 kHz			
Test Mode	Full Load	Half Load	Empty Load		
Position A(A/m)	0.045	0.043	0.047		
Position B(A/m)	0.047	0.045	0.044		
Position C(A/m)	0.040	0.043	0.046		
Position D(A/m)	0.050	0.047	0.045		
Position E(A/m)	0.045	0.044	0.050		
Limits (A/m)	1.630				
50% Limits (A/m)	0.815				

2.6. Test Result for Test setupB:

E-Filed Strength at (distance 10cm to 1cm at 1cm iteration, i.e. at a distance of 10cm, 9cm, 8cm, 1cm, Which is between the edge of the charger and the edge of of probe,) surrounding the EUT (V/m)

the ECT (V/m)							
Test distance (cm)	Position A (V/m)	Position B (V/m)	Position C (V/m)	Position D (V/m)	Position E (V/m)	Limits (V/m)	
1	8.515	9.154	5.956	10.644	12.645	614	
2	7.412	7.154	3.658	8.004	10.564	614	
3	6.715	5.512	2.495	5.403	8.644	614	
4	4.231	4.131	2.465	3.669	6.115	614	
5	3.261	2.355	2.016	2.426	4.654	614	
6	2.546	1.324	1.561	1.912	2.456	614	
7	1.513	1.184	1.245	1.654	1.656	614	
8	1.321	1.001	1.015	1.564	1.306	614	
9	1.010	0.956	0.865	1.011	0.894	614	
10	0.954	0.765	0.545	0.645	0.756	614	

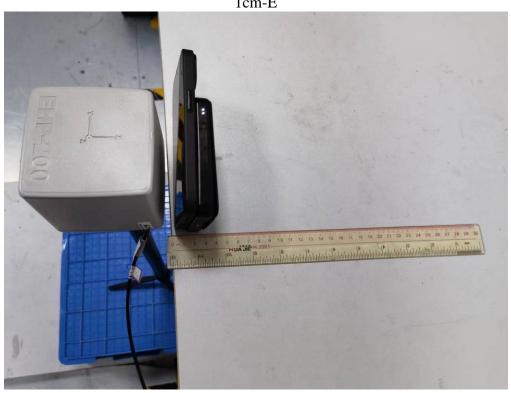
H-Filed Strength at (distance 10cm to 1cm at 1cm iteration, i.e. at a distance of 10cm, 9cm, 8cm, 1cm, Which is between the edge of the charger and the edge of of probe,) surrounding the EUT (A/m)

Test distance (cm)	Position A (A/m)	Position B (A/m)	Position C (A/m)	Position D (A/m)	Position E (A/m)	Limits (A/m)
1	0.138	0.121	0.085	0.126	0.123	1.63
2	0.112	0.117	0.078	0.115	0.114	1.63
3	0.103	0.091	0.075	0.104	0.111	1.63
4	0.089	0.085	0.063	0.091	0.093	1.63
5	0.084	0.071	0.060	0.076	0.0885	1.63
6	0.052	0.065	0.056	0.074	0.071	1.63
7	0.047	0.053	0.054	0.051	0.068	1.63
8	0.052	0.046	0.050	0.039	0.051	1.63
9	0.044	0.045	0.045	0.035	0.050	1.63
10	0.035	0.036	0.037	0.035	0.042	1.63

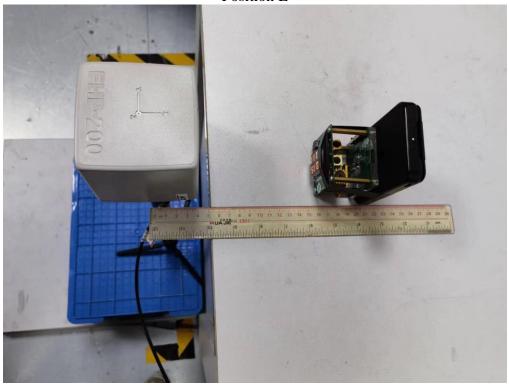
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3. TEST SETUP PHOTO





Position E



End of Test Report



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